

# Military Plastic pASIC 3 Family



60,000 Usable PLD Gate pASIC3 FPGA Combining High Performance and High Density

## DEVICE HIGHLIGHTS

### High Performance and High Density

- 60,000 Usable PLD Gates with 316 I/Os
- 16-bit counter speeds over 300 MHz, data path speeds over 400 MHz
- 0.35um four-layer metal non-volatile CMOS process for smallest die sizes

### Easy to Use/Fast Development Cycles

- 100% routable with 100% utilization and complete pin-out stability
- Variable-grain logic cells provide high performance and 100% utilization
- Comprehensive design tools include high quality Verilog/VHDL synthesis

### Advanced I/O Capabilities

- Interfaces with both 3.3 volt and 5.0 volt devices
- PCI compliant with 3.3V and 5.0V buses for -1/-2 speed grades
- Full JTAG boundary scan
- Registered I/O cells with individually controlled clocks and output enables

## FEATURES

### Total of 180 I/O pins

- 308 bidirectional input/output pins, PCI-compliant for 5.0 volt and 3.3 volt buses for -1/-2 speed grades
- 8 high-drive input/distributed network pins

### Eight Low-Skew Distributed Networks

- Two array clock/control networks available to the logic cell flip-flop clock, set and reset inputs - each driven by an input-only pin
- Up to six global clock/control networks available to the logic cell F1, clock, set and reset inputs and the input and I/O register clock, reset and enable inputs as well as the output enable control - each driven by an input-only or I/O pin, or any logic cell output or I/O cell feedback

### High Performance

- Input + logic cell + output total delays under 6 ns
- Data path speeds exceeding 400 MHz
- Counter speeds over 300 MHz

Device	ASIC Gates	PLD Gates	Package	Max I/O	Qualification Level	Supply Voltage
QL3012	8,000	12,000	84PLCC	68	M	3.3V
QL3025	16,000	25,000	208PQFP	174	M	3.3V
QL3040	24,000	40,000	208PQFP	174	M	3.3V
QL3060	36,000	60,000	208PQFP	174	M	3.3V

M = Military Temperature (-55 to +125 degrees C)

TABLE 1: Selector Table

# Military Plastic pASIC 3 Family

## PRODUCT SUMMARY

The pASIC 3 FPGA family features up to 60,000 usable PLD gates. pASIC 3 FPGAs are fabricated on a 0.35mm four-layer metal process using QuickLogic's patented ViaLink technology to provide a unique combination of high performance, high density, low cost, and extreme ease-of-use.

The pASIC 3 product family contains 1,584 logic cells. With a maximum of 316 I/Os, and is available in 208-PQFP and 84-PLCC packages.

Software support for the complete pASIC 3 family is available through three basic packages. The turnkey QuickWorks® package provides the most complete FPGA software solution from design entry to logic synthesis, to place and route, to simulation. The QuickWorks™-Lite and QuickTools™ packages provide a solution for designers who use Cadence, Exemplar, Mentor, Synopsys, Synplicity, Viewlogic, Veribest, or other third-party tools for design entry, synthesis, or simulation.

## PINOUT DIAGRAM 84-PIN PLCC

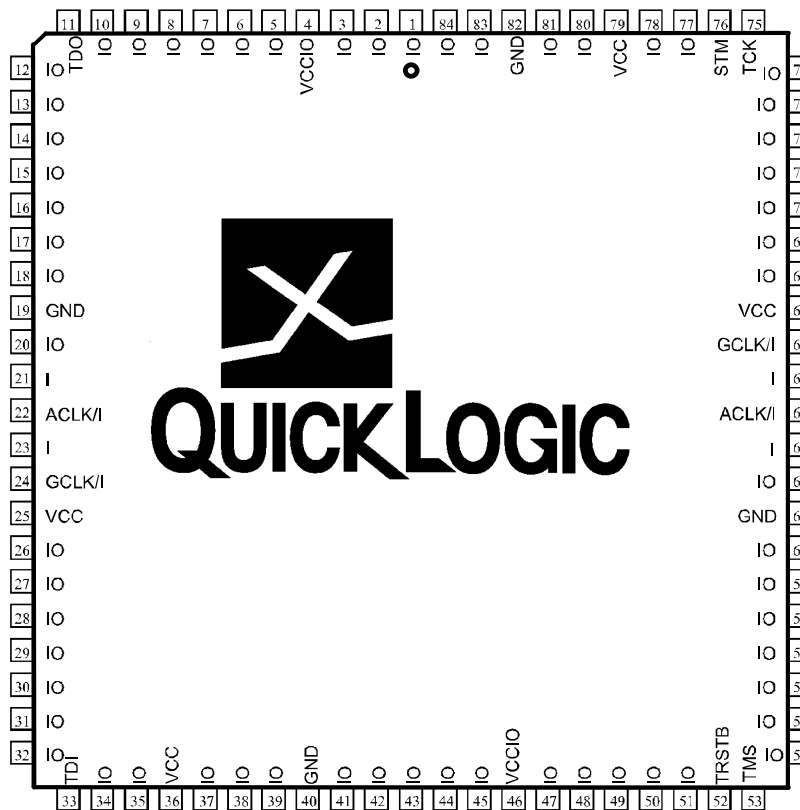
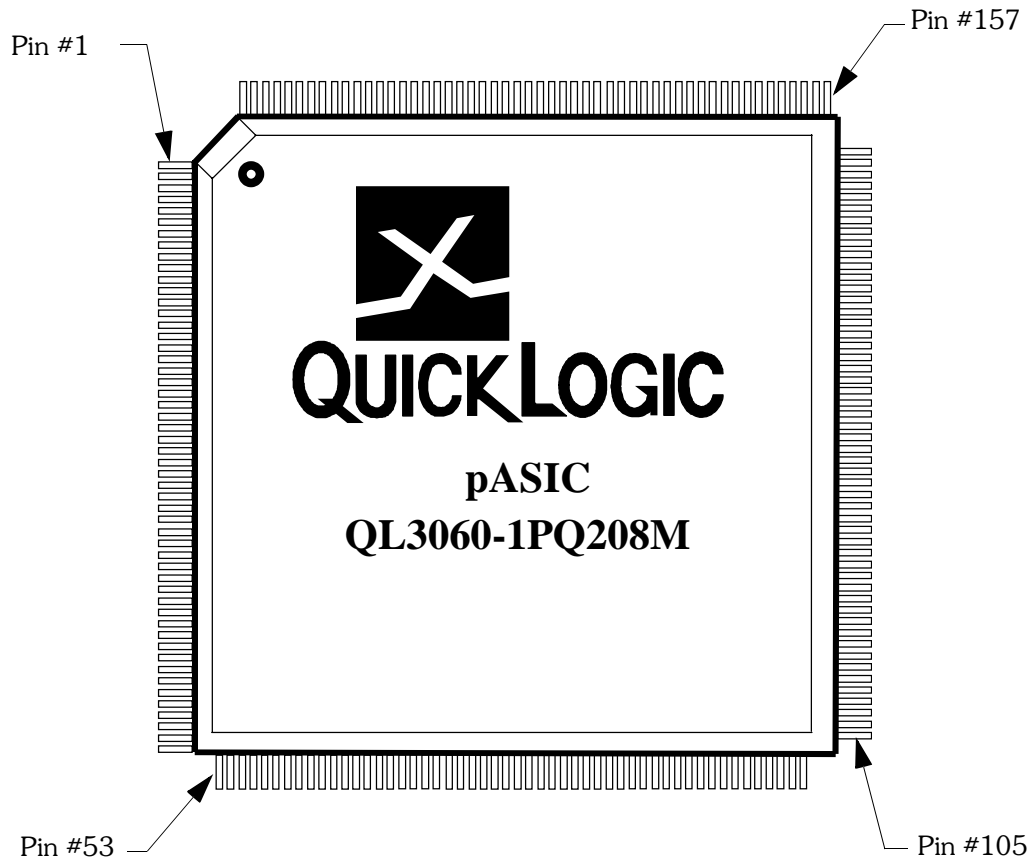


TABLE 2: 84-pin PLCC



# Military Plastic pASIC 3 Family

## PINOUT DIAGRAM 208-PIN PQFP



# Military Plastic pASIC 3 Family

## PQFP 208-PINOUT TABLE

208 PQFP	Function	208 PQFP	Function	208 PQFP	Function	208 PQFP	Function	208 PQFP	Function
208	I/O	43	GND	84	I/O	125	I/O	168	I/O
1	I/O	44	I/O	85	I/O	126	I/O	169	I/O
2	I/O	45	I/O	86	I/O	127	GND	NC	I/O
3	I/O	46	I/O	87	I/O	128	I/O	170	I/O
4	I/O	47	I/O	88	I/O	NC	I/O	171	I/O
5	I/O	48	I/O	89	I/O	129	GCLK / I	172	I/O
NC	I/O	NC	I/O	90	I/O	130	ACLK / I	173	I/O
6	I/O	49	I/O	91	I/O	131	VCC	174	I/O
7	I/O	50	I/O	92	I/O	132	GCLK / I	175	I/O
8	I/O	51	I/O	NC	I/O	133	GCLK / I	NC	I/O
9	I/O	52	I/O	93	I/O	134	VCC	176	I/O
10	VCC	53	I/O	94	I/O	135	I/O	177	GND
11	I/O	54	TDI	95	GND	136	I/O	178	I/O
12	GND	NC	I/O	96	I/O	NC	I/O	179	I/O
13	I/O	NC	I/O	97	VCC	137	I/O	NC	I/O
14	I/O	55	I/O	98	I/O	NC	GND	180	I/O
NC	I/O	56	I/O	99	I/O	138	I/O	181	I/O
15	I/O	NC	I/O	100	I/O	139	I/O	182	GND
16	I/O	57	I/O	NC	I/O	140	I/O	NC	VCC
17	I/O	58	I/O	101	I/O	141	I/O	183	I/O
18	I/O	59	GND	NC	I/O	142	I/O	184	I/O
19	I/O	60	I/O	102	I/O	NC	I/O	185	I/O
20	I/O	61	VCC	NC	I/O	143	I/O	186	I/O
NC	I/O	62	I/O	NC	I/O	144	I/O	187	VCCIO
21	I/O	63	I/O	103	TRSTB	145	VCC	188	I/O
22	I/O	64	I/O	104	TMS	NC	I/O	NC	I/O
23	GND	NC	I/O	105	I/O	146	I/O	189	I/O
24	I/O	65	I/O	NC	I/O	147	GND	190	I/O
25	GCLK / I	66	I/O	106	I/O	148	I/O	191	I/O
26	ACLK / I	67	I/O	107	I/O	149	I/O	192	I/O
27	VCC	NC	I/O	108	I/O	150	I/O	193	I/O
28	GCLK / I	68	I/O	109	I/O	151	I/O	194	I/O
29	GCLK / I	69	I/O	NC	I/O	152	I/O	NC	I/O
30	VCC	70	I/O	110	I/O	153	I/O	195	I/O
31	I/O	NC	I/O	111	I/O	154	I/O	196	I/O
32	I/O	71	I/O	112	I/O	155	I/O	197	I/O
NC	GND	NC	I/O	113	I/O	156	I/O	198	I/O
33	I/O	72	I/O	114	VCC	157	TCK	NC	I/O
NC	I/O	73	GND	115	I/O	158	STM	199	GND
34	I/O	74	I/O	116	GND	NC	I/O	200	I/O
35	I/O	NC	VCC	117	I/O	159	I/O	201	VCC
36	I/O	75	I/O	NC	I/O	160	I/O	202	I/O
NC	I/O	76	I/O	118	I/O	161	I/O	203	I/O
37	I/O	77	I/O	119	I/O	162	I/O	204	I/O
38	I/O	78	GND	120	I/O	163	GND	205	I/O
39	I/O	79	I/O	121	I/O	164	I/O	206	I/O
NC	I/O	80	I/O	NC	I/O	165	VCC	207	TDO
40	I/O	81	I/O	122	I/O	166	I/O		
41	VCC	82	I/O	123	I/O	NC	I/O		
42	I/O	83	VCCIO	124	I/O	167	I/O		



# Military Plastic pASIC 3 Family

## ABSOLUTE MAXIMUM RATINGS

VCC Voltage.....	-0.5 to 4.6V	DC Input Current .....	±20 mA
VCCIO Voltage .....	-0.5 to 7.0V	ESD Pad Protection .....	±2000V
Input Voltage.....	-0.5 to VCCIO+0.5V	Storage Temperature .....	-65°C to +150°C
Latch-up Immunity .....	±200 mA	Lead Temperature .....	300°C

## OPERATING RANGE

Symbol	Parameter	Military		Unit	
		Min	Max		
VCC	Supply Voltage	3.0	3.6	V	
VCCIO	I/O Input Tolerance Voltage	3.0	5.5	V	
TA	Ambient Temperature	-55		°C	
TC	Case Temperature		125	°C	
K	Delay Factor	-0 Speed Grade	0.42	2.03	
		-1 Speed Grade	0.42	1.64	
		-2 Speed Grade	0.42	1.37	

## DC CHARACTERISTICS

Symbol	Parameter	Conditions	Min	Max	Unit
VIH	Input HIGH Voltage		0.5VCC	VCCIO+0.5	V
VIL	Input LOW Voltage		-0.5	0.3VCC	V
VOH	Output HIGH Voltage	IOH = -12 mA	2.4		V
		IOH = -500 µA	0.9VCC		V
VOL	Output LOW Voltage	IOL = 8 mA [1]		0.45	V
		IOL = 1.5 mA		0.1VCC	V
II	I or I/O Input Leakage Current	VI = VCCIO or GND	-10	10	µA
IOZ	3-State Output Leakage Current	VI = VCCIO or GND	-10	10	µA
CI	Input Capacitance [2]			10	pF
IOS	Output Short Circuit Current [3]	VO = GND	-15	-180	mA
		VO = VCC	40	210	mA
ICC	D.C. Supply Current [4]	VI, VIO = VCCIO or GND	0.50 (typ)	5	mA
ICCIO	D.C. Supply Current on VCCIO		0	100	µA

Notes:

- [1] Military devices have 8 mA IOL specifications.
- [2] Capacitance is sample tested only. Clock pins are 12 pF maximum.
- [3] Only one output at a time. Duration should not exceed 30 seconds.
- [4] Maximum ICC is 5 mA for all military grade devices. For AC conditions, contact QuickLogic customer engineering.

# Military Plastic pASIC 3 Family

## QL3012

### AC CHARACTERISTICS at VCC = 3.3V, TA = 25°C (K = 1.00)

(To calculate delays, multiply the appropriate K factor in the "Operating Range" section by the following numbers.)

#### Logic Cells

Symbol	Parameter	Propagation Delays (ns)				
		Fanout [5]				
		1	2	3	4	8
tPD	Combinatorial Delay [6]	1.4	1.7	1.9	2.2	3.2
tSU	Setup Time [6]	1.7	1.7	1.7	1.7	1.7
tH	Hold Time	0.0	0.0	0.0	0.0	0.0
tCLK	Clock to Q Delay	0.7	1.0	1.2	1.5	2.5
tCWHI	Clock High Time	1.2	1.2	1.2	1.2	1.2
tCWLO	Clock Low Time	1.2	1.2	1.2	1.2	1.2
tSET	Set Delay	1.0	1.3	1.5	1.8	2.8
tRESET	Reset Delay	0.8	1.1	1.3	1.6	2.6
tSW	Set Width	1.9	1.9	1.9	1.9	1.9
tRW	Reset Width	1.8	1.8	1.8	1.8	1.8

#### Input-Only/Clock Cells

Symbol	Parameter	Propagation Delays (ns)						
		Fanout [5]						
		1	2	3	4	8	12	24
tIN	High Drive Input Delay	1.5	1.6	1.8	1.9	2.4	2.9	4.4
tINI	High Drive Input, Inverting Delay	1.6	1.7	1.9	2.0	2.5	3.0	4.5
tISU	Input Register Set-Up Time	3.1	3.1	3.1	3.1	3.1	3.1	3.1
tIH	Input Register Hold Time	0.0	0.0	0.0	0.0	0.0	0.0	0.0
tICLK	Input Register Clock To Q	0.7	0.8	1.0	1.1	1.6	2.1	3.6
tIRST	Input Register Reset Delay	0.6	0.7	0.9	1.0	1.5	2.0	3.5
tIESU	Input Register clock Enable Set-Up Time	2.3	2.3	2.3	2.3	2.3	2.3	2.3
tIEH	Input Register Clock Enable Hold Time	0.0	0.0	0.0	0.0	0.0	0.0	0.0

Notes:

- [5] Stated timing for worst case Propagation Delay over process variation at VCC=3.3V and TA=25°C. Multiply by the appropriate Delay Factor, K, for speed grade, voltage and temperature settings as specified in the Operating Range.
- [6] These limits are derived from a representative selection of the slowest paths through the pASIC 3 logic cell including typical net delays. Worst case delay values for specific paths should be determined from timing analysis of your particular design.



# Military Plastic pASIC 3 Family

## QL3012 Clock Cells

Symbol	Parameter	Propagation Delays (ns) Loads per Half Column [7]						
		1	2	3	4	8	10	11
tACK	Array Clock Delay	1.2	1.2	1.3	1.3	1.5	1.6	1.7
tGCKP	Global Clock Pin Delay	0.7	0.7	0.7	0.7	0.7	0.7	0.7
tGCKB	Global Clock Buffer Delay	0.8	0.8	0.9	0.9	1.1	1.2	1.3

## I/O Cells

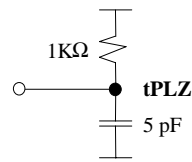
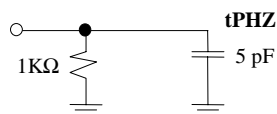
Symbol	Parameter	Propagation Delays (ns) Fanout [5]					
		1	2	3	4	8	10
tI/O	Input Delay (bidirectional pad)	1.3	1.6	1.8	2.1	3.1	3.6
tISU	Input Register Set-Up Time	3.1	3.1	3.1	3.1	3.1	3.1
tIH	Input Register Hold Time	0.0	0.0	0.0	0.0	0.0	0.0
tIOCLK	Input Register Clock To Q	0.7	1.0	1.2	1.5	2.5	3.0
tIORST	Input Register Reset Delay	0.6	0.9	1.1	1.4	2.4	2.9
tIESU	Input Register clock Enable Set-Up Time	2.3	2.3	2.3	2.3	2.3	2.3
tIEH	Input Register Clock Enable Hold Time	0.0	0.0	0.0	0.0	0.0	0.0

Symbol	Parameter	Propagation Delays (ns) Output Load Capacitance (pF)				
		30	50	75	100	150
tOUTLH	Output Delay Low to High	2.1	2.5	3.1	3.6	4.7
tOUTH	Output Delay High to Low	2.2	2.6	3.2	3.7	4.8
tPZH	Output Delay Tri-state to High	1.2	1.7	2.2	2.8	3.9
tPZL	Output Delay Tri-state to Low	1.6	2.0	2.6	3.1	4.2
tPHZ	Output Delay High to Tri-State [8]	2.0				
tPLZ	Output Delay Low to Tri-State [8]	1.2				

Notes:

[7] The array distributed networks consist of 40 half columns and the global distributed networks consist of 44 half columns, each driven by an independent buffer. The number of half columns used does not affect clock buffer delay. The array clock has up to 8 loads per half column. The global clock has up to 11 loads per half column.

[8] The following loads are used for tPXZ:



# Military Plastic pASIC 3 Family

## QL3025

### AC CHARACTERISTICS at VCC = 3.3V, TA = 25°C (K = 1.00)

(To calculate delays, multiply the appropriate K factor in the "Operating Range" section by the following numbers.)

#### Logic Cells

Symbol	Parameter	Propagation Delays (ns) Fanout [5]				
		1	2	3	4	8
tPD	Combinatorial Delay [6]	1.4	1.7	1.9	2.2	3.2
tSU	Setup Time [6]	1.7	1.7	1.7	1.7	1.7
tH	Hold Time	0.0	0.0	0.0	0.0	0.0
tCLK	Clock to Q Delay	0.7	1.0	1.2	1.5	2.5
tCWHI	Clock High Time	1.2	1.2	1.2	1.2	1.2
tCWLO	Clock Low Time	1.2	1.2	1.2	1.2	1.2
tSET	Set Delay	1.0	1.3	1.5	1.8	2.8
tRESET	Reset Delay	0.8	1.1	1.3	1.6	2.6
tSW	Set Width	1.9	1.9	1.9	1.9	1.9
tRW	Reset Width	1.8	1.8	1.8	1.8	1.8

#### Input-Only/Clock Cells

Symbol	Parameter	Propagation Delays (ns) Fanout [5]						
		1	2	3	4	8	12	24
tIN	High Drive Input Delay	1.5	1.6	1.8	1.9	2.4	2.9	4.4
tINI	High Drive Input, Inverting Delay	1.6	1.7	1.9	2.0	2.5	3.0	4.5
tISU	Input Register Set-Up Time	3.1	3.1	3.1	3.1	3.1	3.1	3.1
tIH	Input Register Hold Time	0.0	0.0	0.0	0.0	0.0	0.0	0.0
tICLK	Input Register Clock To Q	0.7	0.8	1.0	1.1	1.6	2.1	3.6
tIRST	Input Register Reset Delay	0.6	0.7	0.9	1.0	1.5	2.0	3.5
tIESU	Input Register clock Enable Set-Up Time	2.3	2.3	2.3	2.3	2.3	2.3	2.3
tIEH	Input Register Clock Enable Hold Time	0.0	0.0	0.0	0.0	0.0	0.0	0.0

Notes:

- [5] Stated timing for worst case Propagation Delay over process variation at VCC=3.3V and TA=25°C. Multiply by the appropriate Delay Factor, K, for speed grade, voltage and temperature settings as specified in the Operating Range.
- [6] These limits are derived from a representative selection of the slowest paths through the pASIC 3 logic cell including typical net delays. Worst case delay values for specific paths should be determined from timing analysis of your particular design.





# Military Plastic pASIC 3 Family

## QL3025 Clock Cells

Symbol	Parameter	Propagation Delays (ns) Loads per Half Column [7]							
		1	2	3	4	8	10	12	15
tACK	Array Clock Delay	1.2	1.2	1.3	1.3	1.5	1.6	1.7	1.8
tGCKP	Global Clock Pin Delay	0.7	0.7	0.7	0.7	0.7	0.7	0.7	0.7
tGCKB	Global Clock Buffer Delay	0.8	0.8	0.9	0.9	1.1	1.2	1.3	1.4

## I/O Cells

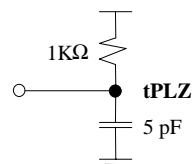
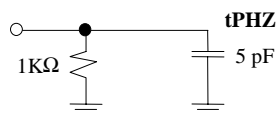
Symbol	Parameter	Propagation Delays (ns) Fanout [5]					
		1	2	3	4	8	10
tI/O	Input Delay (bidirectional pad)	1.3	1.6	1.8	2.1	3.1	3.6
tISU	Input Register Set-Up Time	3.1	3.1	3.1	3.1	3.1	3.1
tIH	Input Register Hold Time	0.0	0.0	0.0	0.0	0.0	0.0
tIOCLK	Input Register Clock To Q	0.7	1.0	1.2	1.5	2.5	3.0
tIORST	Input Register Reset Delay	0.6	0.9	1.1	1.4	2.4	2.9
tIESU	Input Register clock Enable Set-Up Time	2.3	2.3	2.3	2.3	2.3	2.3
tIEH	Input Register Clock Enable Hold Time	0.0	0.0	0.0	0.0	0.0	0.0

Symbol	Parameter	Propagation Delays (ns) Output Load Capacitance (pF)				
		30	50	75	100	150
tOUTLH	Output Delay Low to High	2.1	2.5	3.1	3.6	4.7
tOUTH	Output Delay High to Low	2.2	2.6	3.2	3.7	4.8
tPZH	Output Delay Tri-state to High	1.2	1.7	2.2	2.8	3.9
tPZL	Output Delay Tri-state to Low	1.6	2.0	2.6	3.1	4.2
tPHZ	Output Delay High to Tri-State [8]	2.0				
tPLZ	Output Delay Low to Tri-State [8]	1.2				

Notes:

[7] The array distributed networks consist of 56 half columns and the global distributed networks consist of 60 half columns, each driven by an independent buffer. The number of half columns used does not affect clock buffer delay. The array clock has up to 12 loads per half column. The global clock has up to 15 loads per half column.

[8] The following loads are used for tPXZ:



# Military Plastic pASIC 3 Family

## QL3040

### AC CHARACTERISTICS at VCC = 3.3V, TA = 25°C (K = 1.00)

(To calculate delays, multiply the appropriate K factor in the "Operating Range" section by the following numbers.)

#### Logic Cells

Symbol	Parameter	Propagation Delays (ns) Fanout [5]				
		1	2	3	4	8
tPD	Combinatorial Delay [6]	1.4	1.7	1.9	2.2	3.2
tSU	Setup Time [6]	1.7	1.7	1.7	1.7	1.7
tH	Hold Time	0.0	0.0	0.0	0.0	0.0
tCLK	Clock to Q Delay	0.7	1.0	1.2	1.5	2.5
tCWHI	Clock High Time	1.2	1.2	1.2	1.2	1.2
tCWLO	Clock Low Time	1.2	1.2	1.2	1.2	1.2
tSET	Set Delay	1.0	1.3	1.5	1.8	2.8
tRESET	Reset Delay	0.8	1.1	1.3	1.6	2.6
tSW	Set Width	1.9	1.9	1.9	1.9	1.9
tRW	Reset Width	1.8	1.8	1.8	1.8	1.8

#### Input-Only/Clock Cells

Symbol	Parameter	Propagation Delays (ns) Fanout [5]						
		1	2	3	4	8	12	24
tIN	High Drive Input Delay	1.5	1.6	1.8	1.9	2.4	2.9	4.4
tINI	High Drive Input, Inverting Delay	1.6	1.7	1.9	2.0	2.5	3.0	4.5
tISU	Input Register Set-Up Time	3.1	3.1	3.1	3.1	3.1	3.1	3.1
tIH	Input Register Hold Time	0.0	0.0	0.0	0.0	0.0	0.0	0.0
tICLK	Input Register Clock To Q	0.7	0.8	1.0	1.1	1.6	2.1	3.6
tIRST	Input Register Reset Delay	0.6	0.7	0.9	1.0	1.5	2.0	3.5
tIESU	Input Register clock Enable Set-Up Time	2.3	2.3	2.3	2.3	2.3	2.3	2.3
tIEH	Input Register Clock Enable Hold Time	0.0	0.0	0.0	0.0	0.0	0.0	0.0

Notes:

- [5] Stated timing for worst case Propagation Delay over process variation at VCC=3.3V and TA=25°C. Multiply by the appropriate Delay Factor, K, for speed grade, voltage and temperature settings as specified in the Operating Range.
- [6] These limits are derived from a representative selection of the slowest paths through the pASIC 3 logic cell including typical net delays. Worst case delay values for specific paths should be determined from timing analysis of your particular design.



# Military Plastic pASIC 3 Family

## QL3040 Clock Cells

Symbol	Parameter	Propagation Delays (ns) Loads per Half Column [7]								
		1	2	3	4	8	10	12	14	16
tACK	Array Clock Delay	1.2	1.2	1.3	1.3	1.5	1.6	1.7	1.8	1.9
tGCKP	Global Clock Pin Delay	0.7	0.7	0.7	0.7	0.7	0.7	0.7	0.7	0.7
tGCKB	Global Clock Buffer Delay	0.8	0.8	0.9	0.9	1.1	1.2	1.3	1.4	1.5

## I/O Cells

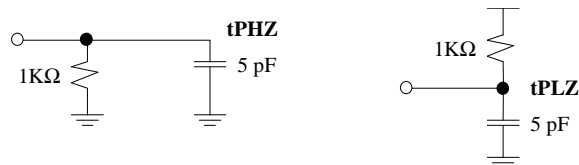
Symbol	Parameter	Propagation Delays (ns) Fanout [5]					
		1	2	3	4	8	10
tI/O	Input Delay (bidirectional pad)	1.3	1.6	1.8	2.1	3.1	3.6
tISU	Input Register Set-Up Time	3.1	3.1	3.1	3.1	3.1	3.1
tIH	Input Register Hold Time	0.0	0.0	0.0	0.0	0.0	0.0
tIOCLK	Input Register Clock To Q	0.7	1.0	1.2	1.5	2.5	3.0
tIORST	Input Register Reset Delay	0.6	0.9	1.1	1.4	2.4	2.9
tIESU	Input Register clock Enable Set-Up Time	2.3	2.3	2.3	2.3	2.3	2.3
tIEH	Input Register Clock Enable Hold Time	0.0	0.0	0.0	0.0	0.0	0.0

Symbol	Parameter	Propagation Delays (ns) Output Load Capacitance (pF)				
		30	50	75	100	150
tOUTLH	Output Delay Low to High	2.1	2.5	3.1	3.6	4.7
tOUTH	Output Delay High to Low	2.2	2.6	3.2	3.7	4.8
tPZH	Output Delay Tri-state to High	1.2	1.7	2.2	2.8	3.9
tPZL	Output Delay Tri-state to Low	1.6	2.0	2.6	3.1	4.2
tPHZ	Output Delay High to Tri-State [8]	2.0				
tPLZ	Output Delay Low to Tri-State [8]	1.2				

Notes:

[7] The array distributed networks consist of 72 half columns and the global distributed networks consist of 76 half columns, each driven by an independent buffer. The number of half columns used does not affect clock buffer delay. The array clock has up to 14 loads per half column. The global clock has up to 16 loads per half column.

[8] The following loads are used for tPXZ:



# Military Plastic pASIC 3 Family

## QL3060

### AC CHARACTERISTICS at VCC = 3.3V, TA = 25°C (K = 1.00)

(To calculate delays, multiply the appropriate K factor in the "Operating Range" section by the following numbers.)

#### Logic Cells

Symbol	Parameter	Propagation Delays (ns) Fanout [5]				
		1	2	3	4	8
tPD	Combinatorial Delay [6]	1.4	1.7	1.9	2.2	3.2
tSU	Setup Time [6]	1.7	1.7	1.7	1.7	1.7
tH	Hold Time	0.0	0.0	0.0	0.0	0.0
tCLK	Clock to Q Delay	0.7	1.0	1.2	1.5	2.5
tCWHI	Clock High Time	1.2	1.2	1.2	1.2	1.2
tCWLO	Clock Low Time	1.2	1.2	1.2	1.2	1.2
tSET	Set Delay	1.0	1.3	1.5	1.8	2.8
tRESET	Reset Delay	0.8	1.1	1.3	1.6	2.6
tSW	Set Width	1.9	1.9	1.9	1.9	1.9
tRW	Reset Width	1.8	1.8	1.8	1.8	1.8

#### Input-Only/Clock Cells

Symbol	Parameter	Propagation Delays (ns) Fanout [5]						
		1	2	3	4	8	12	24
tIN	High Drive Input Delay	1.5	1.6	1.8	1.9	2.4	2.9	4.4
tNI	High Drive Input, Inverting Delay	1.6	1.7	1.9	2.0	2.5	3.0	4.5
tISU	Input Register Set-Up Time	3.1	3.1	3.1	3.1	3.1	3.1	3.1
tIH	Input Register Hold Time	0.0	0.0	0.0	0.0	0.0	0.0	0.0
tICLK	Input Register Clock To Q	0.7	0.8	1.0	1.1	1.6	2.1	3.6
tIRST	Input Register Reset Delay	0.6	0.7	0.9	1.0	1.5	2.0	3.5
tIESU	Input Register clock Enable Set-Up Time	2.3	2.3	2.3	2.3	2.3	2.3	2.3
tIEH	Input Register Clock Enable Hold Time	0.0	0.0	0.0	0.0	0.0	0.0	0.0

Notes:

- [5] Stated timing for worst case Propagation Delay over process variation at VCC=3.3V and TA=25°C. Multiply by the appropriate Delay Factor, K, for speed grade, voltage and temperature settings as specified in the Operating Range.
- [6] These limits are derived from a representative selection of the slowest paths through the pASIC 3 logic cell including typical net delays. Worst case delay values for specific paths should be determined from timing analysis of your particular design.



# Military Plastic pASIC 3 Family

## QL3060 Clock Cells

Symbol	Parameter	Propagation Delays (ns) Loads per Half Column [7]										
		1	2	3	4	8	10	12	14	16	18	20
tACK	Array Clock Delay	1.2	1.2	1.3	1.3	1.5	1.6	1.7	1.8	1.9	2	2.1
tGCKP	Global Clock Pin Delay	0.7	0.7	0.7	0.7	0.7	0.7	0.7	0.7	0.7	0.7	0.7
tGCKB	Global Clock Buffer Delay	0.8	0.8	0.9	0.9	1.1	1.2	1.3	1.4	1.5	1.6	1.7

## I/O Cells

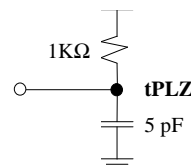
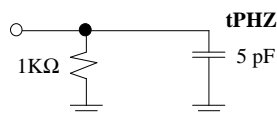
Symbol	Parameter	Propagation Delays (ns) Fanout [5]					
		1	2	3	4	8	10
tI/O	Input Delay (bidirectional pad)	1.3	1.6	1.8	2.1	3.1	3.6
tISU	Input Register Set-Up Time	3.1	3.1	3.1	3.1	3.1	3.1
tIH	Input Register Hold Time	0.0	0.0	0.0	0.0	0.0	0.0
tIOCLK	Input Register Clock To Q	0.7	1.0	1.2	1.5	2.5	3.0
tIORST	Input Register Reset Delay	0.6	0.9	1.1	1.4	2.4	2.9
tIESU	Input Register clock Enable Set-Up Time	2.3	2.3	2.3	2.3	2.3	2.3
tIEH	Input Register Clock Enable Hold Time	0.0	0.0	0.0	0.0	0.0	0.0

Symbol	Parameter	Propagation Delays (ns) Output Load Capacitance (pF)				
		30	50	75	100	150
tOUTLH	Output Delay Low to High	2.1	2.5	3.1	3.6	4.7
tOUTH	Output Delay High to Low	2.2	2.6	3.2	3.7	4.8
tPZH	Output Delay Tri-state to High	1.2	1.7	2.2	2.8	3.9
tPZL	Output Delay Tri-state to Low	1.6	2.0	2.6	3.1	4.2
tPHZ	Output Delay High to Tri-State [8]	2.0				
tPLZ	Output Delay Low to Tri-State [8]	1.2				

Notes:

[7] The array distributed networks consist of 88 half columns and the global distributed networks consist of 92 half columns, each driven by an independent buffer. The number of half columns used does not affect clock buffer delay. The array clock has up to 18 loads per half column. The global clock has up to 20 loads per half column.

[8] The following loads are used for tPXZ:



# Military Plastic pASIC 3 Family

## Pin Descriptions

Pin	Function	Description
TDI	Test Data In for JTAG	Hold HIGH during normal operation. Connect to VCC if not used for JTAG.
TRSTB	Active low Reset for JTAG	Hold LOW during normal operation. Connect to ground if not used for JTAG.
TMS	Test Mode Select for JTAG	Hold HIGH during normal operation. Connect to VCC if not used for JTAG.
TCK	Test Clock for JTAG	Hold HIGH or LOW during normal operation. Connect to VCC or ground if not used for JTAG.
TDO	Test data out for JTAG	Output that must be left unconnected if not used for JTAG.
STM	Special Test Mode	Must be grounded during normal operation.
I/ACLK	High-drive input and/or array network driver	Can be configured as either or both.
I/GCLK	High-drive input and/or global network driver	Can be configured as either or both.
I	High-drive input	Use for input signals with high fanout.
I/O	Input/Output pin	Can be configured as an input and/or output.
VCC	Power supply pin	Connect to 3.3V supply.
VCCIO	Input voltage tolerance pin	Connect to 5.0 volt supply if 5 volt input tolerance is required, otherwise connect to 3.3V supply.
GND	Ground pin	Connect to ground.
GND/THERM	Ground/Thermal pin	Available on 456-PBGA only. Connect to ground plane on PCB if heat sinking desired. Otherwise may be left unconnected.

## Ordering Information

**QL 3060 -1 PQ208 M**

